



MachXO3 Hardware Checklist

Technical Note

FPGA-TN-02061-1.4

March 2024

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Inclusive Language

This document was created consistent with Lattice Semiconductor's inclusive language policy. In some cases, the language in underlying tools and other items may not yet have been updated. Please refer to Lattice's inclusive language [FAQ 6878](#), for a cross reference of terms. Note in some cases such as register names and state names it has been necessary to continue to utilize older terminology for compatibility.

Contents

Contents	3
Acronyms in This Document	6
1. Introduction	7
2. Power Supply	8
2.1. Power Noise	8
2.2. Power Source	8
3. Power Supply Filtering	9
3.1. Recommended Power Filtering Groups and Components	9
4. Power Estimation	10
5. Power Sequencing	11
6. Configuration Considerations	12
7. Controller SPI (MSPI)	17
8. PROGRAMN Initial Power Considerations	18
9. Pinout Considerations	19
10. sysI/O	20
11. True-LVDS Output Pin Assignments	21
12. PCI Clamp Pin Assignment	22
13. Clock Inputs	23
14. Issue: GPIO Input(s) Prevents Powering Down the FPGA	24
14.1. GPIO Input Current Leakage Pathway	24
14.2. Workarounds	24
15. Layout Recommendations	25
16. Checklist	26
References	27
Technical Support Assistance	28
Revision History	29

Figures

Figure 3.1. Recommended Power Filter Group	9
Figure 6.1. Typical Connections for Programming SRAM or Internal Flash via JTAG.....	13
Figure 6.2. Typical Connections for Programming SRAM or Internal Flash via SSPI	14
Figure 6.3. Typical Connections for Programming SRAM or Internal Flash via I ² C	15
Figure 6.4. Typical Connections for Programming External Flash via JTAG	16
Figure 13.1. Clock Oscillator Bypassing.....	23
Figure 13.2. PCB Dual Footprint Supporting HCSL and LVDS Oscillators	23
Figure 14.1. Potential Current Path for Powered Down FPGA with Driven Input	24
Figure 15.1. PCB Layout Recommendation.....	25

Tables

Table 2.1. Power Supply Description and Voltage Levels	8
Table 3.1. Recommended Power Filtering Groups and Components.....	9
Table 6.1. Default State of the sysCONFIG Pins ¹	12
Table 10.1. Weak Pull-up/Pull-down Current Specifications.....	20
Table 16.1. Hardware Checklist	26

Acronyms in This Document

A list of acronyms used in this document.

Acronym	Definition
PCB	Printed Circuit Board
I ² C	Inter-Integrated Circuit
SRAM	Static Random Access Memory
NVCM	Non Volatile Configuration Memory

1. Introduction

When designing complex hardware using the MachXO3™ PLD, specifically the L version, designers must pay special attention to critical hardware configuration requirements. This technical note steps through these critical hardware requirements related to the MachXO3L/LF devices. This document does not provide detailed step-by-step instructions but gives a high-level summary checklist to assist in the design process.

The MachXO3L/LF ultra-low power, instant-on, non-volatile PLDs are available in two versions C and E devices. C devices have an internal linear voltage regulator which supports external V_{CC} supply voltages of 3.3 V or 2.5 V. E devices only accept 1.2 V as the external V_{CC} supply voltage. With the exception of power supply voltage, both types of devices (C and E) are functionally and pin compatible with each other.

This technical note assumes that the reader is familiar with the MachXO3L/LF device features as described in the [MachXO3 Family Data Sheet \(FPGA-DS-02032\)](#).

The critical hardware areas covered in this technical note include:

- Power supplies as they relate to the MachXO3L/LF supply rails and how to connect them to the PCB and the associated system.
- Configuration and how to connect the configuration mode selection for proper power up configuration.
- Device I/O interface and critical signals.

Important: Refer to the following documents for detailed recommendations.

- [Power Decoupling and Bypass Filtering for Programmable Devices \(FPGA-TN-02083\)](#)
- [Power and Thermal Estimation and Management for MachXO3 Devices \(FPGA-TN-02059\)](#)
- [MachXO3 sysIO Usage Guide \(FPGA-TN-02056\)](#)
- [Implementing High-Speed Interfaces with MachXO3 Devices \(FPGA-TN-02057\)](#)
- [MachXO3 Programming and Configuration Usage Guide \(FPGA-TN-02055\)](#)
- [Using Hardened Control Functions in MachXO3 Devices \(FPGA-TN-02063\)](#)

2. Power Supply

The V_{CC} and V_{CCIO0} power supplies determine the MachXO3L/LF internal *power good* condition. These supplies need to be at a valid and stable level before the device can become operational. In addition, there are five (V_{CCIO1} to V_{CCIO5}) supplies that power the remaining I/O banks. [Table 2.1](#) shows the power supplies and the appropriate voltage levels for each.

Refer to the [MachXO3 Family Data Sheet \(FPGA-DS-02032\)](#) for more information on the voltage levels.

Table 2.1. Power Supply Description and Voltage Levels

Supply	Voltage (Nominal Value)	Description
V_{CC}	1.2 V	Core power supply for 1.2 V devices (E)
	2.5 V/3.3 V	Core power supply for 2.5 V/3.3 V devices (C)
V_{CCIOx}	1.2 V to 3.3 V	Power supply pins for I/O Bank x. There are up to five I/O banks.

2.1. Power Noise

The power rail voltages of the FPGA allow for a worst-case normal operating tolerance of $\pm 5\%$ of these voltages. The 5% tolerance includes any noise.

2.2. Power Source

It is recommended that the designed voltage regulators are accurate to within 3% of the optimum voltage to allow power noise design margin.

When calculating the voltage regulator total tolerance, include:

- Regulator voltage reference tolerance
- Regulator line tolerance
- Regulator load tolerance
- Tolerances of any resistors connected to the regulator’s feedback pin, which sets the regulator’s output voltage
- Expected voltage drops due to the power filtering ferrite bead’s ESR * expected current draw
- Expected voltage drops due to the current measuring resistor’s ESR * expected current draw.

With a 3% tolerance allocated to the voltage source, the design has a remaining 2% tolerance for noise and layout-related issues. The 1.2 V rail is especially sensitive to noise, as every 12 mV is 1% of the rail voltage.

3. Power Supply Filtering

Providing a quiet, filtered supply is important for all rails and critical for the analog rails. Supplies should be decoupled with adequate power filters. Bypass capacitors must be located close to the device package pins with very short traces to keep inductance low.

For the best performance, use careful pin assignments to keep noisy I/O pins away from sensitive functional pins. The leading causes of PCB-related crosstalk with sensitive blocks are related to FPGA outputs located in close proximity to the sensitive power supplies. These supplies require cautious board layout to ensure noise immunity to the switching noise generated by FPGA outputs. Guidelines are provided to build quiet-filtered supplies for the analog supplies; however, robust PCB layout is required to ensure that noise does not infiltrate into these analog supplies.

3.1. Recommended Power Filtering Groups and Components

Table 3.1. Recommended Power Filtering Groups and Components

Power Input	Recommended Filter	Notes
V _{CC}	10 μF x 2 + 100 nF per pin	Core and clock logic. 1.2 V devices (E) 2.5 V/3.3 V devices (C)
V _{CCIO[6:0]}	10 μF + 100 nF per pin for each V _{CCIOx}	Bank I/O. Unused banks can use a single 1.0 μF. For banks with lots of outputs or large capacitive loading replace the 10 μF with a 22 μF (or use two 10 μF). 1.2 V, 1.5 V, 1.8 V, 2.5 V, 3.3 V

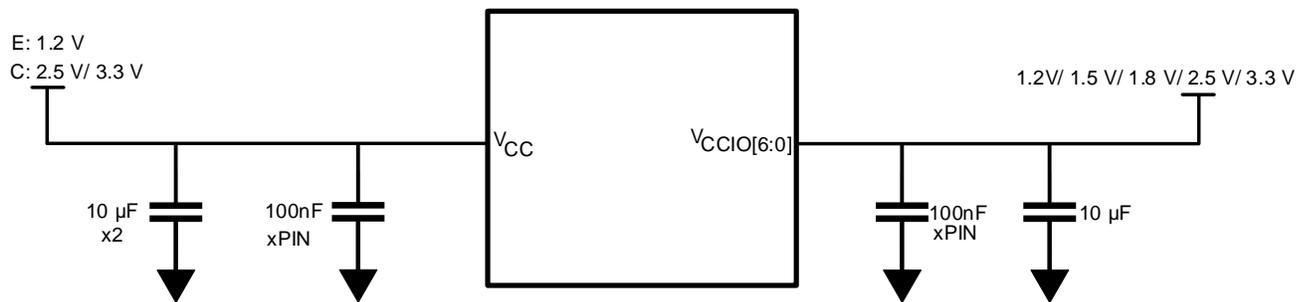


Figure 3.1. Recommended Power Filter Group

4. Power Estimation

Once the MachXO3L/LF device density, package, and logic implementation are decided, power estimation can be performed using the Power Calculator tool, which is provided as part of the Lattice Diamond® design software. While performing power estimation, the user should keep two specific goals in mind.

- Power supply budgeting should be considered based on the maximum power-up in-rush current, configuration current, or maximum DC and AC current for a given system environmental condition.
- The ability of the system environment and MachXO3L/LF device packaging to support the specified maximum operating junction temperature.

By determining these two criteria, system design planning can take the MachXO3L/LF power requirements into consideration early in the design phase.

This is explained in [Power and Thermal Estimation and Management for MachXO3 Devices \(FPGA-TN-02059\)](#).

5. Power Sequencing

There is no power sequence required for the MachXO3 devices.

6. Configuration Considerations

MachXO3L/LF devices contain two types of memory, SRAM and either NVCM in MachXO3L devices or Flash in MachXO3LF devices. SRAM is volatile memory and contains the active configuration. NVCM, or Flash, is non-volatile memory that provides on-chip storage for the SRAM configuration data.

The MachXO3L/LF includes multiple programming and configuration interfaces:

- 1149.1 JTAG
- Self-download
- Target SPI (SSPI)
- Controller SPI (MSPI)
- Dual Boot
- I²C
- WISHBONE bus

For ease of prototype debugging, it is recommended that every PCB have easy access to the programming and configuration pins.

The configuration logic arbitrates access from the interfaces by the following priority. When higher priority ports are enabled, NVCM or Flash access by lower priority ports will be blocked.

- JTAG Port
- Target SPI (SSPI) Port (SN low activates the SPI port)
- I²C Primary Port

Note: Erased devices have all programming and configuration ports enabled by default. When the device is erased ensure that SN and ProgramN are not driven low.

For a detailed description of the programming and configuration interfaces, please refer to the [MachXO3 Programming and Configuration Usage Guide \(FPGA-TN-02055\)](#).

The use of external resistors is always needed if the configuration signals are being used to handshake with other devices. Pull-up and pull-down resistor (4.7K) recommendations on different configuration pins are listed below.

Table 6.1. Default State of the sysCONFIG Pins¹

Pin Name	Pin Function (Configuration Mode)	Pin Direction (8-Bit Size)	Data In Bits that Get Masked (9-Bit Size)
PROGRAMN	PROGRAMN	Input with weak pull-up, external pull-up to V _{CCIO0} .	PROGRAMN
INITN	I/O	I/O with weak pull-up, external pull-up V _{CCIO0} .	User-defined I/O
DONE	I/O	I/O with weak pull-up, external pull-up to V _{CCIO0} .	User-defined I/O
MCLK/CCLK	SSPI	Input with weak pull-up. MCLK function requires external 1k Ω pull-up.	User-defined I/O
SN	SSPI	Input with weak pull-up, external pull-up to V _{CCIO2} .	User-defined I/O
SI/SPISI	SSPI	Input	User-defined I/O
SO/SOSPI	SSPI	Output	User-defined I/O
CSSPIN	I/O	I/O with weak pull-up, external pullup to V _{CCIO2} .	User-defined I/O
SCL	I ² C	Bi-Directional open drain, external pull-up, noise filter (200 Ω series/100pF to GND)	User-defined I/O
SDA	I ² C	Bi-Directional open drain, external pull-up, noise filter 1(00 Ω series/100pF to GND)	User-defined I/O
TDI	TDI	Input with weak pull-up.	TDI
TDO	TDO	Output with weak pull-up.	TDO
TCK	TCK	Input. Recommended 4.7k Ω pull-down.	TCK
TMS	TMS	Input with weak pull-up.	TMS
JTAGENB	I/O	Input with weak pull-down.	I/O

Note:

1. Leave the unused configuration ports open.

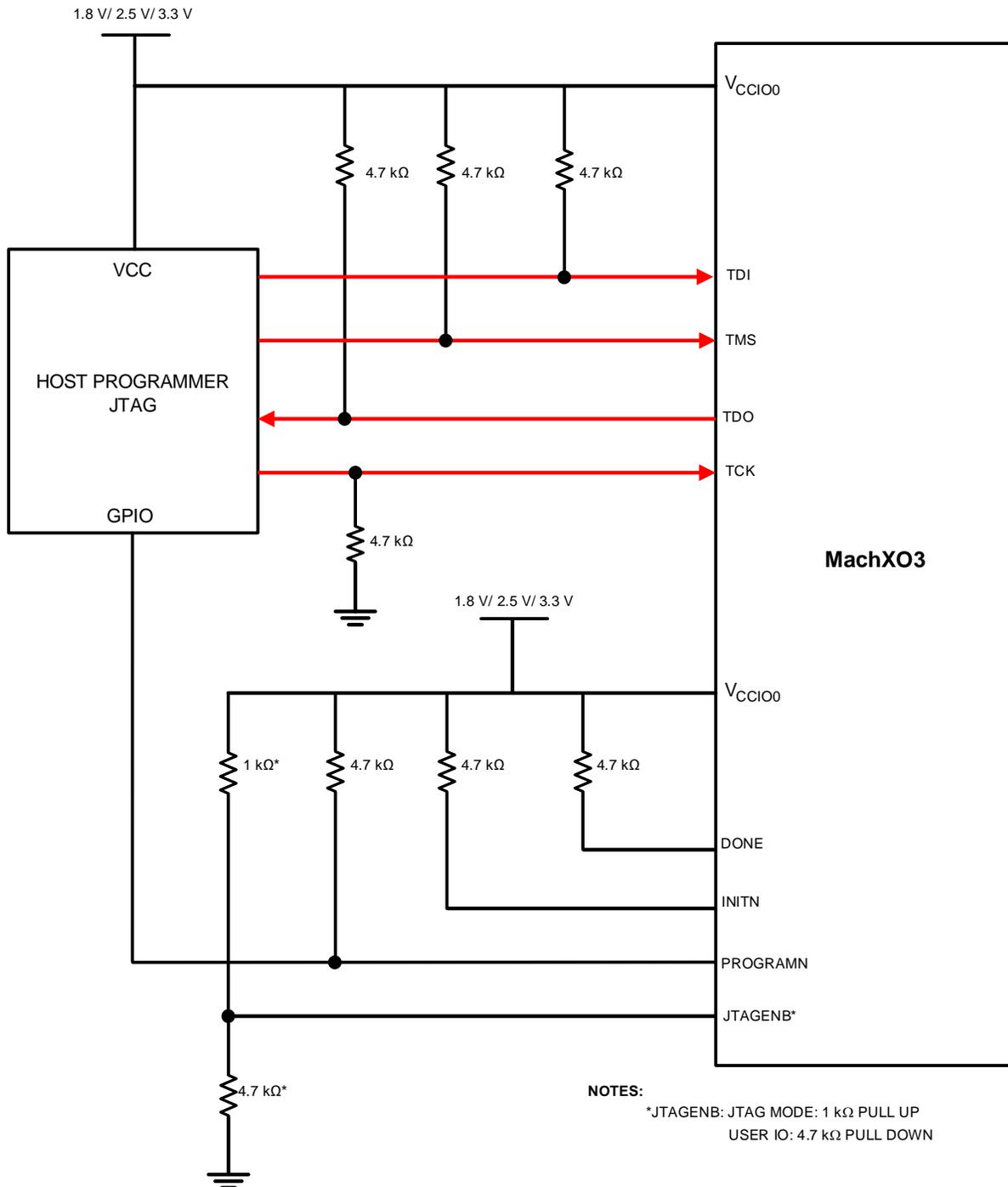


Figure 6.1. Typical Connections for Programming SRAM or Internal Flash via JTAG

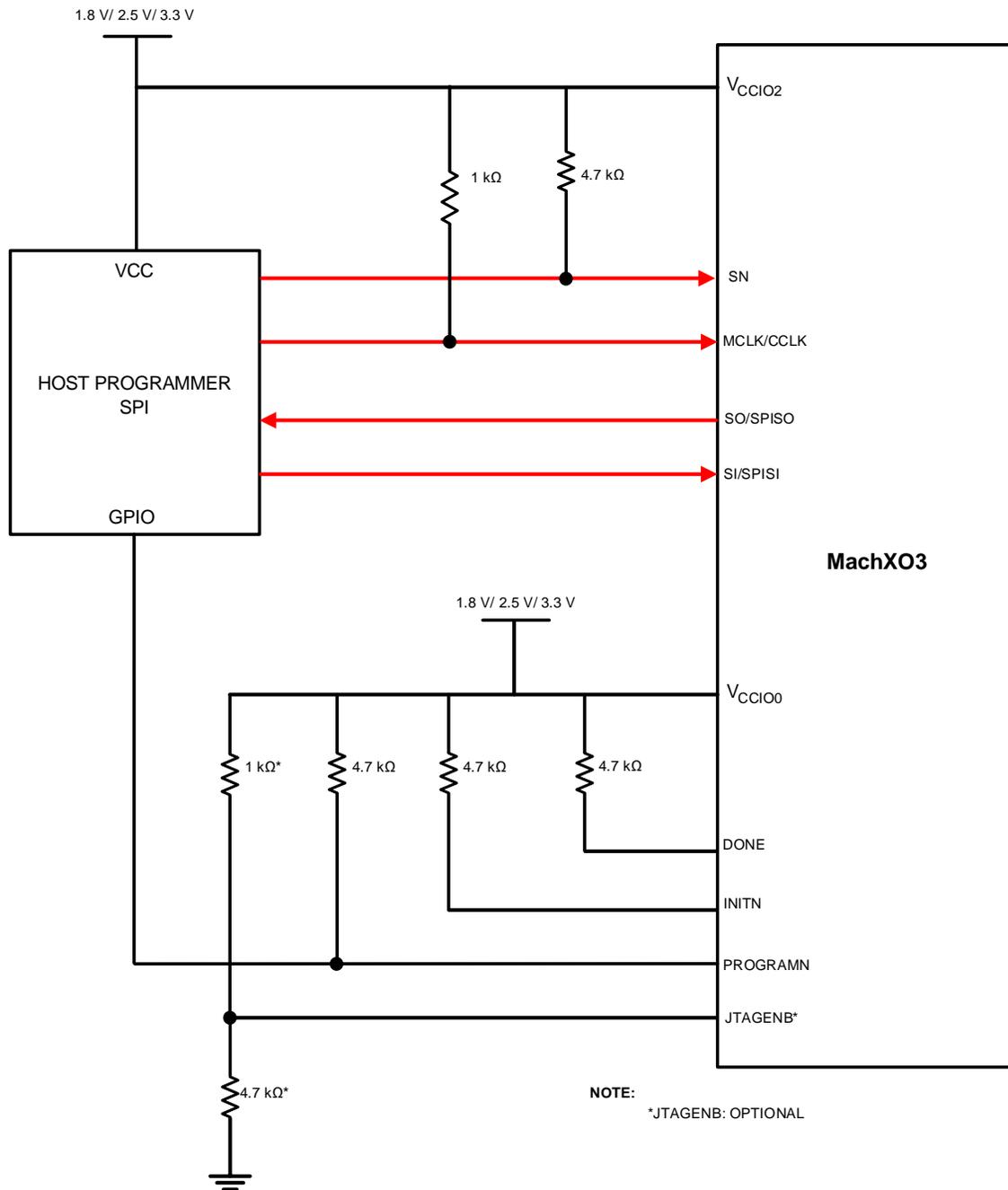


Figure 6.2. Typical Connections for Programming SRAM or Internal Flash via SSPI

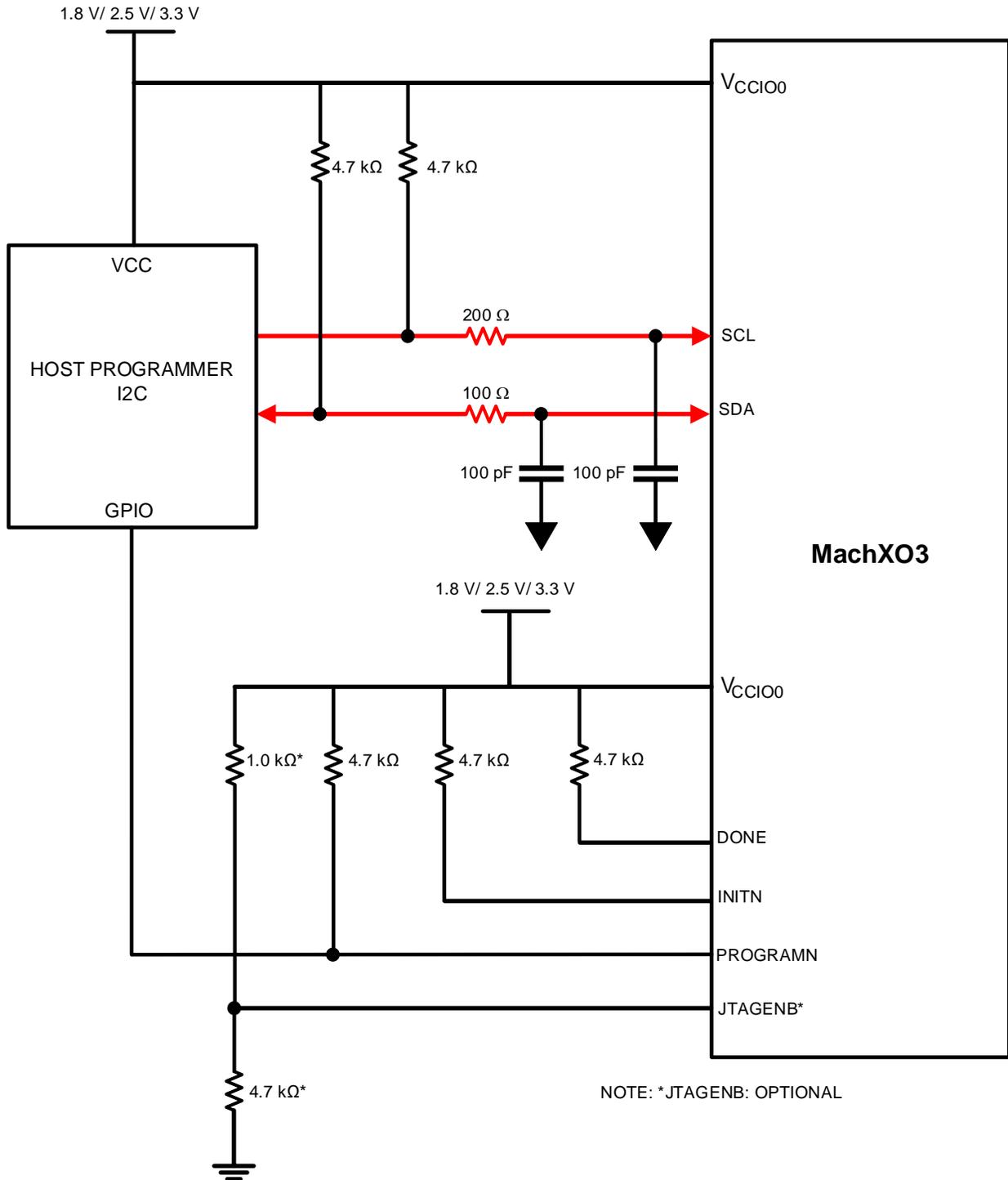


Figure 6.3. Typical Connections for Programming SRAM or Internal Flash via I²C

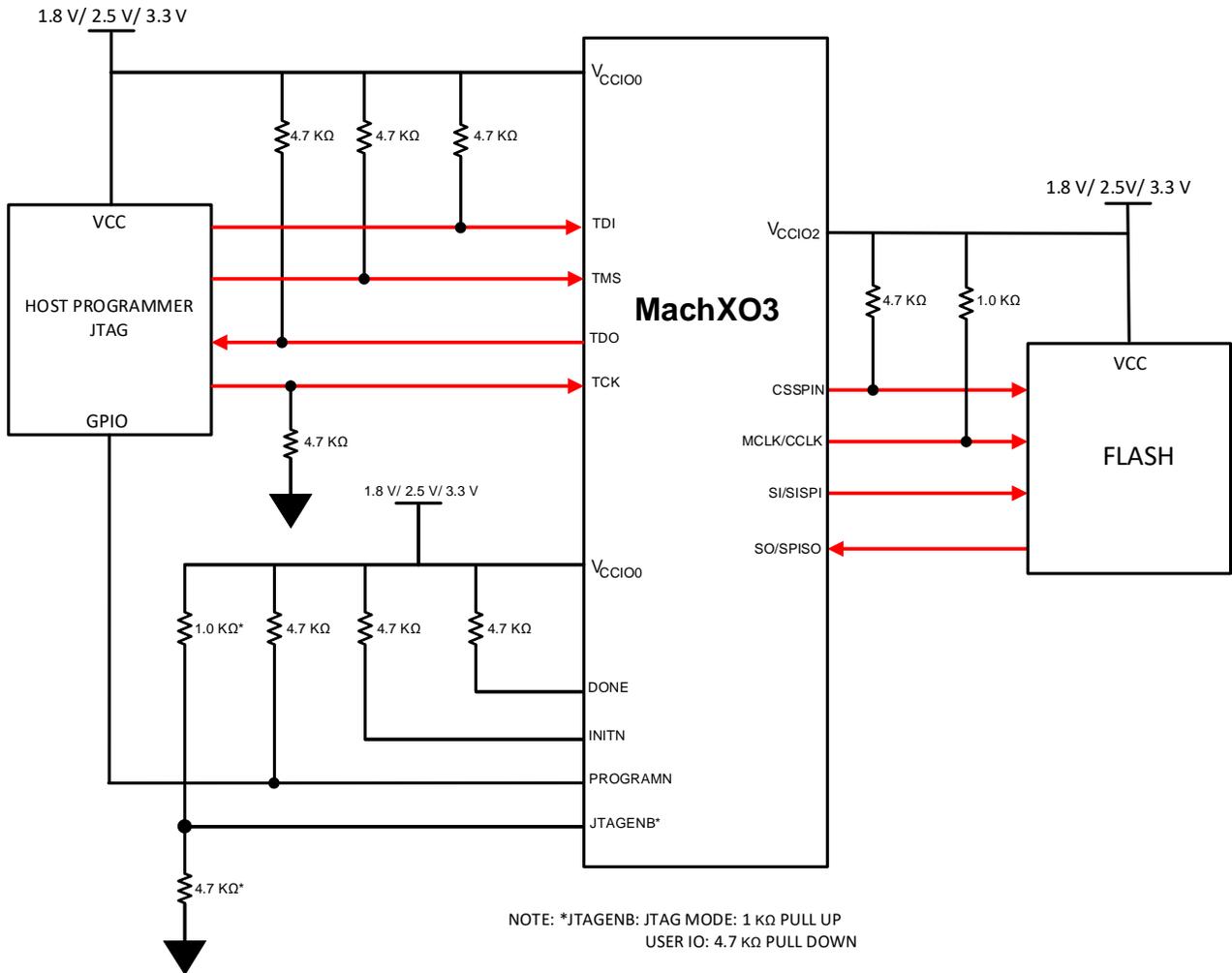


Figure 6.4. Typical Connections for Programming External Flash via JTAG

7. Controller SPI (MSPI)

When configuring from an external SPI Flash:

- The SPI Flash VCC and the MachXO3L/LF VCCIO2 are at the same level.
- The SPI Flash VCC is at the recommended operating level. The SPI Flash should be supported in Diamond Programmer. To see the supported list of devices, go to Diamond Programmer, under the **Help** menu, choose **Help**, then search for **SPI Flash support**.
- For SPI Flash devices that are not listed in the **SPI Flash Support**, using the custom flash option may allow a non supported device to work.

8. PROGRAMN Initial Power Considerations

The MachXO3L/LF PROGRAMN is permitted to become a general-purpose I/O. The PROGRAMN only becomes a general-purpose I/O after the configuration bitstream is loaded. When power is applied to the MachXO3L/LF, the PROGRAMN input performs the PROGRAMN function. It is critical that any signal input to the PROGRAMN have a high-to-low transition period that is longer than the V_{CC} (min) to INITN rising edge time period. Transitions faster than this time period prevent the MachXO3L/LF from becoming operational. Refer to the description of PROGRAMN in the [MachXO3 Programming and Configuration Usage Guide \(FPGA-TN-02055\)](#).

9. Pinout Considerations

The MachXO3L/LF PLDs support many applications with high-speed interfaces. These include various rule-based pin-outs that need to be understood prior to the implementation of the PCB design. The pin-out selection must be completed with an understanding of the interface building blocks of the FPGA fabric. These include IOLOGIC blocks such as DDR, clock resource connectivity, and PLL usage. Refer to [Implementing High-Speed Interfaces with MachXO3 Devices \(FPGA-TN-02057\)](#) for rules pertaining to these interface types.

10. sysI/O

MachXO3 provides the flexibility to configure each I/O according to the user's requirements. These pins can be configured as input, output, and tri-state. Additionally, attributes such as PULLMODE, CLAMP, HYSTERESIS, VREF, OPENDRAIN, SLEWRATE, DIFFRESISTOR, TERMINATION, and DRIVE STRENGTH can also be setup. Refer to the [MachXO3 sysIO Usage Guide \(FPGA-TN-02056\)](#) for more information on this.

For the PULLMODE, Pull-up and Pull-down resistors can be set. The implementation of these resistors involves using a constant current that has the following values:

Table 10.1. Weak Pull-up/Pull-down Current Specifications

	Parameter	Condition	Min	Max	Unit
Pull-up	I/O Weak Pull-up Resistor Current	$0 \leq V_{IN} \leq 0.7 \times V_{CCIO}$	-30	-309	μA
Pull-down	I/O Weak Pull-down Resistor Current	$V_{IL} (\text{max}) \leq V_{IN} \leq V_{CCIO}$	30	305	μA

11. True-LVDS Output Pin Assignments

True-LVDS outputs are on the top bank (Bank 0) of the MachXO3L/LF-1300 and higher density devices. When using the LVDS outputs, a 2.5 V or 3.3 V supply needs to be connected to the Bank 0 V_{CCIO} supply rails. Refer to the [MachXO3 sysIO Usage Guide \(FPGA-TN-02056\)](#) for more information on this.

12. PCI Clamp Pin Assignment

PCI clamps are available on the bottom I/O bank (Bank 2) of the MachXO3L/LF-1300 and higher density devices. When the system design calls for PCI clamps, these pins should be assigned to I/O Bank 2. For the clamp characteristic, refer to the IBIS buffer models either on the Lattice web site or in the Lattice Diamond design software.

13. Clock Inputs

The MachXO3 device provides certain pins for use as clock inputs in each I/O bank. These pins are shared and can alternately be used for general purpose I/O.

When these pins are used for clocking purposes, you need to pay attention to minimize signal noise on these pins.

These shared clock input pins, typically named PCLK, can be found under the Dual Function column of the pinlist csv file.

High-speed differential interfaces being received by the FPGA must route their differential clock pair into a pair of inputs that support differential clocking, labeled PCLKTx_y (+true) and PCLKCx_y (-complement).

When providing an external reference clock to the FPGA, ensure that the oscillator’s output voltage to the FPGA does not exceed the bank’s voltage. Good power supply decoupling of the clock oscillator is required to reduce clock jitter. A typical bypassing circuit is shown in [Figure 13.1](#).

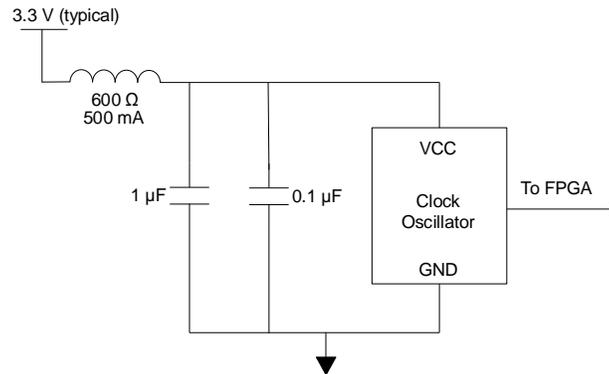


Figure 13.1. Clock Oscillator Bypassing

For differential clock inputs to banks with a V_{CCIO} voltage of 1.5 V or lower, it is recommended to use an HCSL oscillator to keep the clock voltage less than or equal to the bank’s V_{CCIO} . An LVDS oscillator can also be used if AC is coupled and then DC is biased at half the V_{CCIO} voltage. Example dual footprint design supporting HCSL and LVDS is shown below in [Figure 13.2](#).

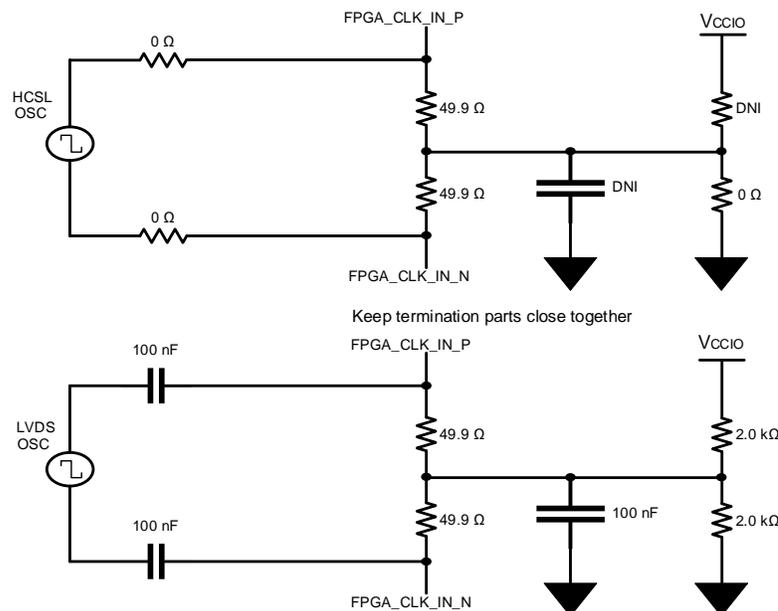


Figure 13.2. PCB Dual Footprint Supporting HCSL and LVDS Oscillators

14. Issue: GPIO Input(s) Prevents Powering Down the FPGA

For C devices where the design involves V_{CC} and bank V_{CCIOx} voltages that are the same (3.3 V or 2.5 V) and connected together, careful design consideration must be followed to avoid the FPGA not powering down fully and left operating in an undefined state.

14.1. GPIO Input Current Leakage Pathway

An external signal driving the GPIO input of a powering-down FPGA can cause a current pathway through the GPIO pin's input clamp diode and then out of the FPGA bank's V_{CCIOx} pin. If this V_{CCIOx} pin is connected to the FPGA's V_{CC} pins, then the FPGA may stay partially powered up in an undefined state.

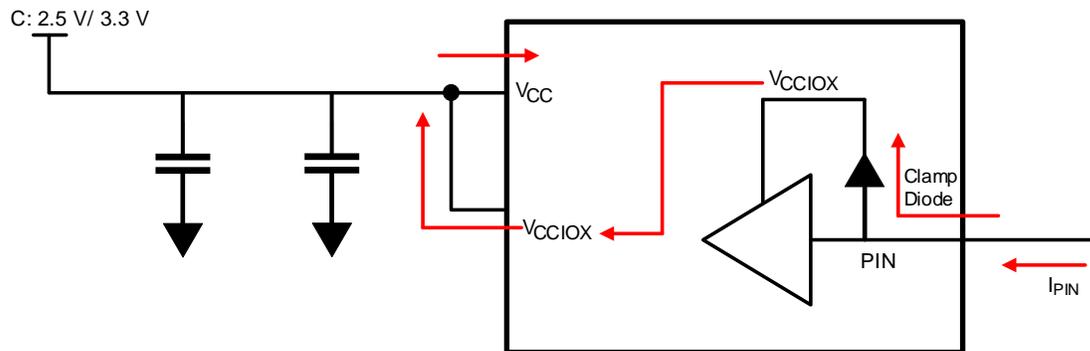


Figure 14.1. Potential Current Path for Powered Down FPGA with Driven Input

14.2. Workarounds

Workaround 1

- Do not enable the clamp diodes for banks whose V_{CCIOx} pins also connect to the FPGA's V_{CC} pins.

Workaround 2

- If the design requires clamp diodes, then the circuit needs to prevent back-drive current from V_{CCIOx} flowing into V_{CC} pins.

15. Layout Recommendations

A good design from a schematic should also reflect a good layout for the system design to work without any issues with noise or power distribution. Below are some of the recommended layouts in general.

1. All power should come from power planes. This is to ensure good power delivery and thermal stability.
2. Each power pin has its own decoupling capacitor, typically 100 nF, that should be placed as close as possible to each other.
3. The placement of analog circuits must be away from digital circuits or high switching components.
4. High-speed signals should have a clearance of five times the trace width of other signals.
5. High-speed signals that transition from one layer to another should have a corresponding transition ground if both reference planes are grounded. If the reference on the other layer is a V_{CC} plane, then a stitching capacitor should be used (ground to V_{CC}).

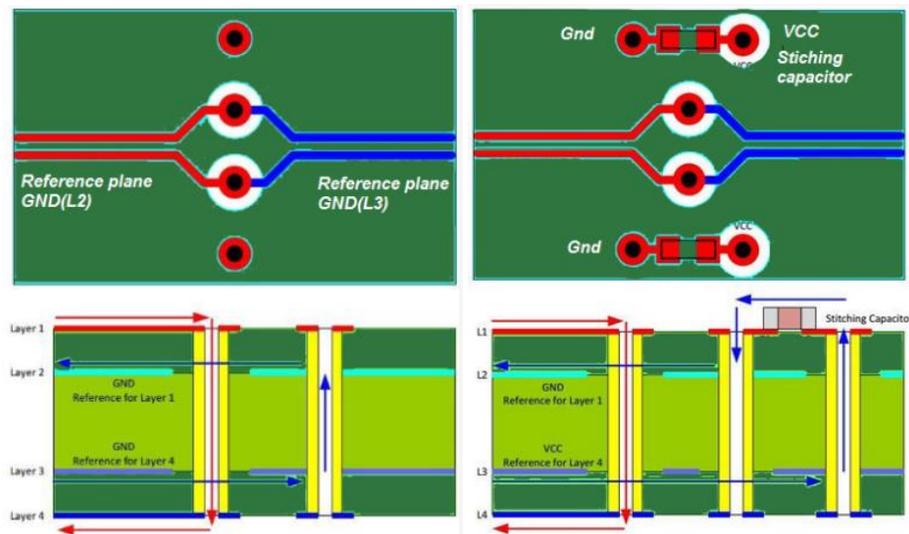


Figure 15.1. PCB Layout Recommendation

6. High-speed signals have a corresponding impedance requirement; calculate the necessary trace width and trace gap (differential gap) according to the desired stack-up. Verify trace dimensions with the PCB vendor.
7. For differential pairs, be sure to match the length as closely as possible. A good rule of thumb is to match up to ± 5 mils.

For further information on layout recommendations, refer to:

- [PCB Layout Recommendations for BGA Packages \(FPGA-TN-02024\)](#)
- [PCB Layout Recommendations for Leaded Packages \(FPGA-TN-02160\)](#)

16. Checklist

Table 16.1. Hardware Checklist

	MachXO3L Hardware Checklist Item	OK	N/A
1	Power Supply		
1.1	Core Supply V_{CC} at 1.2 V		
1.2	Core Supply V_{CC} at 2.5 V or 3.3 V		
1.3	I/O power supply V_{CCIO} 0-5 at 1.2 V to 3.3 V		
1.4	Power Estimation		
1.5	Follow the recommended power filtering groups and components in Table 3.1. Recommended Power Filtering Groups and Components.		
1.6	All ground pins need to be connected to the board's ground plane.		
1.7	Bank I/O supplies.		
1.8	Connect the unused V_{CCIOx} to a power rail. Do not leave it open.		
1.9	All configurations of V_{CCIO} (Banks 0,2), when used with the configuration interfaces (example: SPI Flash Memory Devices), need to match the voltage specifications.		
2	Configuration		
2.1	Configuration options		
2.2	Pull-up on PROGRAMN, INITN, and DONE per Section 6 Configuration Considerations.		
2.3	Pull-up on SPI mode pins, per Section 6 Configuration Considerations.		
2.4	Pull-up on I ² C mode pins, per Section 6 Configuration Considerations.		
2.5	JTAG default logic levels		
2.6	PROGRAMN high-to-low transition time period is larger than the V_{CC} (min) to INITN rising edge time period.		
2.7	The Controller SPI (MSPI) voltage should match V_{CCIO2} voltage.		
3	I ² C Filter		
3.1	RC filter for I2C bus, per Table 6.1. Default State of the sysCONFIG Pins1.		
4	I/O pin assignment		
4.1	True LVDS pin assignment considerations		
4.2	PCI clamp requirement considerations		
4.3	Clock input assignment should be at PCLK.		
5	Issue: GPIO Input(s) Prevents Powering Down the FPGA		
5.1	GPIO input leakage current pathway		
5.2	Workarounds		
6	Layout Recommendations		

References

- [MachXO3 web page](#)
- [MachXO3 Family Data Sheet \(FPGA-DS-02032\)](#)
- [MachXO3 Programming and Configuration Usage Guide \(FPGA-TN-02055\)](#)
- [MachXO3 sysIO Usage Guide \(FPGA-TN-02056\)](#)
- [Implementing High-Speed Interfaces with MachXO3 Devices \(FPGA-TN-02057\)](#)
- [Using Hardened Control Functions in MachXO3 Devices \(FPGA-TN-02063\)](#)
- [Power Decoupling and Bypass Filtering for Programmable Devices \(FPGA-TN-02083\)](#)
- [Power and Thermal Estimation and Management for MachXO3 Devices \(FPGA-TN-02059\)](#)
- [PCB Layout Recommendations for BGA Packages \(FPGA-TN-02024\)](#)
- [PCB Layout Recommendations for Leaded Packages \(FPGA-TN-02160\)](#)
- [Lattice Diamond FPGA design software](#)
- [Lattice Diamond Programmer and Deployment Tool](#)
- [Lattice Insights](#) for Lattice Semiconductor training courses and learning plans

Technical Support Assistance

Submit a technical support case through www.latticesemi.com/techsupport.

For frequently asked questions, refer to the Lattice Answer Database at <https://www.latticesemi.com/Support/AnswerDatabase>.

Revision History

Revision 1.4, March 2024

Section	Change Summary
All	<ul style="list-style-type: none"> Minor editorial fixes. Changed the term <i>Master</i> to <i>Controller</i>. Changed the term <i>Slave</i> to <i>Target</i>.
Disclaimers	Updated this section.
Inclusive language	Added this section.
Power Supply	Added Subsection 2.1 Power Noise and Subsection 2.2 Power Source .
Power Supply Filtering	<ul style="list-style-type: none"> Changed the section title from <i>Power Estimation</i> to <i>Power Supply Filtering</i>. Reworked section contents.
Power Sequencing	Added this section
Configuration Consideration	<ul style="list-style-type: none"> Moved this section to Section 6. Added table note 1 in Table 6.1. Default State of the sysCONFIG Pins1. Updated the <i>Pin Directions</i> of the following pins in Table 6.1. Default State of the sysCONFIG Pins1. <ul style="list-style-type: none"> INITN pin - <i>I/O with weak pull-up, external pull-up to V_{CCIO0}</i>. SCL pin – <i>Bidirectional open drain, external pull-up, noise filter (200 Ω series/100 pF to GND)</i>. SDA pin – <i>Bidirectional open drain, external pull-up, noise filter (100 Ω series/100 pF to GND)</i>. Added Figure 6.1. Typical Connections for Programming SRAM or Internal Flash via JTAG, Figure 6.2. Typical Connections for Programming SRAM or Internal Flash via SSPI, Figure 6.3. Typical Connections for Programming SRAM or Internal Flash via I2C, and Figure 6.4. Typical Connections for Programming External Flash via JTAG.
Controller SPI (MSPI)	<ul style="list-style-type: none"> Moved this section to Section 7. Updated the section name to <i>Controller SPI (MSPI)</i>. Reworked section contents.
Back Leakage Considerations	Removed this section.
sysI/O	Added this section.
Clock Inputs	Added this section.
Issue: GPIO Input(s) Prevents Powering Down the FPGA	Added this section.
Layout Recommendations	Added this section.
Checklist	Reworked section contents.
References	Added this section.
Tech Support Assistance	Added reference to the Lattice Answer Database on the Lattice website.

Revision 1.3, March 2020

Section	Change Summary
All	<ul style="list-style-type: none"> Changed document number from TN1291 to FPGA-TN-02061. Updated document template.
Disclaimers	Added this section.
Back Leakage Considerations	Added this section.

Revision 1.2, March 2016

Section	Change Summary
Master SPI	Minor editorial correction.
Technical Support Assistance	Updated contact information.

Revision 1.1, March 2015

Section	Change Summary
All	Product name/trademark adjustment. Included MachXO3LF device.

Revision 1.0, April 2014

Section	Change Summary
All	Initial release



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